

# Search Notes



Application/Control No.

10/817,249

Examiner

Ryan D. Walsh

Applicant(s)/Patent under Reexamination

NAKANO ET AL.

Art Unit

2852

## SEARCHED

Class	Subclass	Date	Examiner
399	350 <i>updated</i>	9/17/2006 <i>2/2/07</i>	RDW <i>RDW</i>

## INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

## SEARCH NOTES (INCLUDING SEARCH STRATEGY)

	DATE	EXMR
See EAST search history attached <i>updated</i>	9/13/2006 <i>2/2/07</i>	RDW <i>RDW</i>